

# Product Specification

## PE4261 FLIP CHIP

SP4T UltraCMOS™ 2.6 V Switch  
100 – 3000 MHz

Figure 1. Functional Diagram

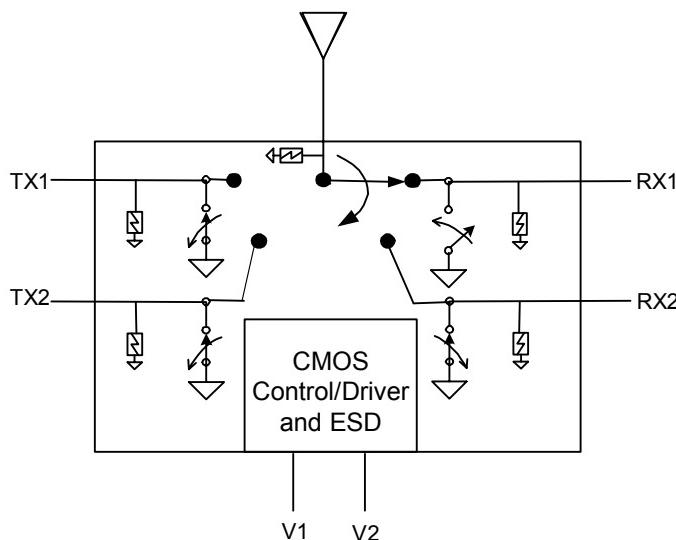
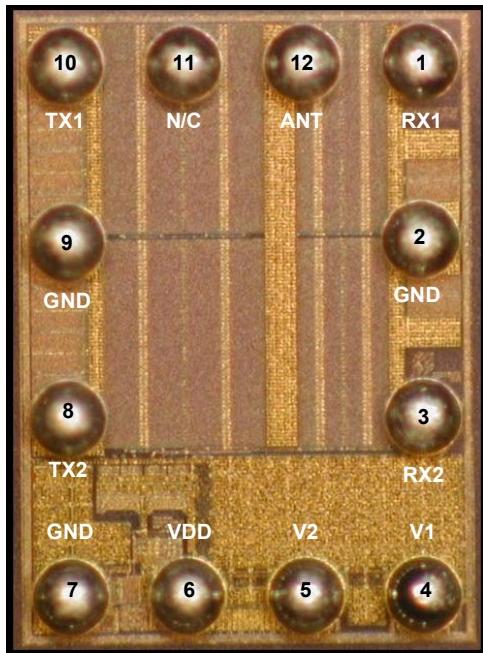


Figure 2. Die Top View



### Features

- Two pin CMOS logic control inputs
- Low TX insertion loss: 0.55 dB at 900 MHz, 0.70 dB at 1900 MHz
- Isolation of 39 dB at 900 MHz, 31 dB at 1900 MHz
- Low harmonics  $2f_o = -82$  dBc and  $3f_o = -74$  dBc at 35 dBm input power
- 1500 V HBM ESD tolerance
- Built in CMOS decoder/driver
- RX SAW over voltage protection circuit
- No blocking capacitors required

### Product Description

The PE4261 SP4T RF UltraCMOS™ Flip Chip Switch is designed specifically to address the needs of the antenna switch module market for GSM Handsets. On-chip CMOS decode logic is used to facilitate two-pin, low voltage CMOS control inputs. High ESD tolerance of 1500 V at all ports, no blocking capacitor requirements and on-chip SAW filter overvoltage protection devices make this the ultimate in integration and ease of use.

The PE4261 is manufactured on Peregrine's UltraCMOS™ process, a patented variation of silicon-on-insulator (SOI) technology on a sapphire substrate, offering the performance of GaAs with the economy and integration of conventional CMOS.

**Table 1. PE4261 Electrical Specifications: Temp = 25°C, V<sub>DD</sub> = 2.6 V**

Parameter	Condition	Min	Typ	Max	Unit
Operational Frequency		100		3000	MHz
Insertion Loss	ANT - TX - 850 / 900 MHz ANT - TX - 1800 / 1900 MHz ANT - RX - 850 / 900 MHz ANT - RX - 1800 / 1900 MHz		0.55 0.7 0.85 1.05	0.65 0.8 1.0 1.2	dB dB dB dB
Isolation	TX - RX - 850 / 900 MHz (TX ON) TX - RX - 1800 / 1900 MHz (TX ON) TX1 - TX2 - 850 / 900 MHz (TX1 ON) TX1 - TX2 - 1800 / 1900 MHz (TX1 ON)	37 29 33 26	39 31 35 28		dB dB dB dB
Return Loss	850 / 900 MHz 1800 / 1900 MHz	18 14	20 16		dB dB
2nd Harmonic <sup>1,2</sup>	35 dBm TX Input Power - 850 / 900 MHz 33 dBm TX Input Power - 1800 / 1900 MHz		-82 -89	-78 -82	dBc dBc
3rd Harmonic <sup>1,2</sup>	35 dBm TX Input Power - 850 / 900 MHz 33 dBm TX Input Power - 1800 / 1900 MHz		-74 -68	-69 -65	dBc dBc
Switching time	(10-90%) (90-10%) RF		2	3	μs

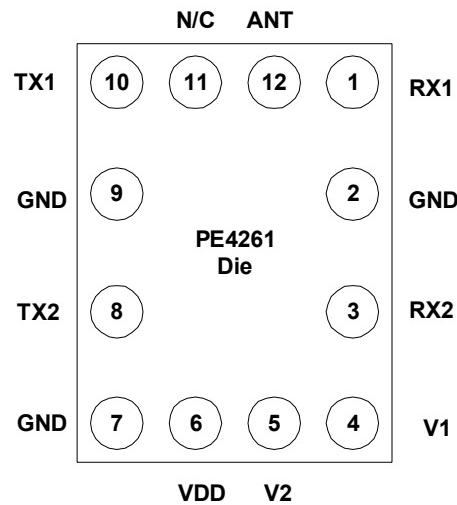
Notes:

1. Measured in Pulsed Wave Mode.

2. Assumes RF input duty cycle of 50% and 4620 μs, measured per 3GPP TS 45.005

**Table 2. Pin Descriptions**

Pin No.	Pin Name	Description
1	RX1 <sup>3</sup>	RF I/O – RX1
2	GND	Ground
3	RX2 <sup>3</sup>	RF I/O – RX2
4	V1	Switch control input, CMOS logic level
5	V2	Switch control input, CMOS logic level
6	VDD	Supply
7	GND	Ground
8	TX2 <sup>3</sup>	RF I/O - TX2
9	GND	Ground
10	TX1 <sup>3</sup>	RF I/O - TX1
11	N/C	No Connect – Pin to be connected to an electrically isolated low capacitance pad
12	ANT <sup>3</sup>	RF Common – Antenna Input

**Figure 3. Pin Configuration (Ball-Side Up)**


Note:

3. Blocking capacitors needed only when non-zero DC voltage present.

**Table 3. Absolute Maximum Ratings**

Symbol	Parameter/Conditions	Min	Max	Units
$V_{DD}$	Power supply voltage	-0.3	4.0	V
$V_I$	Voltage on any input	-0.3	$V_{DD} + 0.3$	V
$T_{ST}$	Storage temperature range	-65	+150	°C
$T_{OP}$	Operating temperature range	-40	+85	°C
$P_{IN}$	TX input power (50 Ω)		+38	dBm
	RX input power (50 Ω)		+23	
$P_{IN} (\infty:1)$	TX input power (VSWR = (∞:1) <sup>5,6</sup> 824-915 MHz)		+35	dBm
	TX input power (VSWR = (∞:1) <sup>5,6</sup> 1710-1910 MHz)		+33	
$V_{ESD}^4$	ESD Voltage (HBM, MIL_STD 883 Method 3015.7)		1500	V
	ESD Voltage (MM, JEDEC, JESD22-A114-B)		100	V
	ESD Voltage (CDM, JEDEC, JESD22-A114-B)		1500	V
	ESD Voltage (IEC 61000-4-2, ANT port)		2000	V

- Note:
- 4. ANT port rated higher per Application note, see page 10.
  - 5. Assumes RF input duty cycle of 50% and 4620 μs.
  - 6.  $V_{DD}$  within operating range specified in Table 4.

Absolute Maximum Ratings are those values listed in the above table. Exceeding these values may cause permanent device damage. Functional operation should be restricted to the limits in the DC Electrical Specifications table. Exposure to absolute maximum ratings for extended periods may affect device reliability.

**Table 4. DC Electrical Specifications**

Parameter	Min	Typ	Max	Units
$V_{DD}$ Power Supply Voltage	2.4	2.6	2.8	V
$I_{DD}$ Power Supply Current ( $V_{DD} = 2.6$ V)		11	25	μA
Control Voltage High	$0.7 \times V_{DD}$			V
Control Voltage Low			$0.3 \times V_{DD}$	V

**Table 5. Truth Table**

Path	V2	V1
ANT - RX1	0	0
ANT - RX2	0	1
ANT - TX1	1	0
ANT - TX2	1	1

### Electrostatic Discharge (ESD) Precautions

When handling this UltraCMOS™ device, observe the same precautions that you would use with other ESD-sensitive devices. Although this device contains circuitry to protect it from damage due to ESD, precautions should be taken to avoid exceeding the specified rating.

### Latch-Up Avoidance

Unlike conventional CMOS devices, UltraCMOS™ devices are immune to latch-up.

**Table 6. Ordering Information**

Order Code	Die ID	Description	Package	Shipping Method
PE4261-93	C9804_3	PE4261-DIE-D	Film Frame	Wafer (Gross Die / Wafer Quantity)
PE4261-96	C9804_3	PE4261-DIE-255G	Waffle Pack	255 Dice / Waffle Pack
PE4261-10	C9804_3	PE4261-DIE-1H	Evaluation Kit	1 / Box

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## Data Sheet Identification

### Advance Information

The product is in a formative or design stage. The data sheet contains design target specifications for product development. Specifications and features may change in any manner without notice.

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### Preliminary Specification

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### Product Specification

The data sheet contains final data. In the event Peregrine decides to change the specifications, Peregrine will notify customers of the intended changes by issuing a DCN (Document Change Notice).